



COLLEGE OF TECHNOLOGY

Program: Diploma Engineering

Branch:(AE/CH/CL/CE/CSE/CSE-CS/CSE-AIML/EE/IT/ME)

Semester – I & II

Internal Backlog Examination, CIE(TH), CIE(PR), ESE(PR)

Sr. No.	Subject Code	Subject Name	Venue	Date	Time
1	2010252103	Fundamentals of Physics	D-507	08/12/2025	10:00 AM to 11:00 AM
2	2010252104	Advanced Physics	D-507	08/12/2025	11:00 AM to 12:00 PM
3	2010272101	Elementary Mathematics	D-507	09/12/2025	10:00 AM to 11:00 AM
4	2010272102	Advanced Mathematics	D-507	09/12/2025	11:00 AM to 12:00 PM
5	2010152181	General English	D-507	10/12/2025	10:00 AM to 11:00 AM
6	2010152182	Professional Development and Communication	D-507	10/12/2025	11:00 AM to 12:00 PM
7	2010122111	Engineering Graphics	D-507	11/12/2025	10:00 AM to 11:00 AM
8	2010262105	Applied Chemistry	D-507	11/12/2025	11:00 AM to 12:00 PM
9	2010082112	Fundamentals of Electrical & Electronics Engineering	D-507	12/12/2025	10:00 AM to 11:00 AM
10	2010122113	Engineering Mechanics	D-509	12/12/2025	10:00 AM to 11:00 AM
11	2010042111	Introduction to C Programming	D-507	12/12/2025	11:00 AM to 12:00 PM
12	2010042112	Introduction to Application Software & Computer Peripherals	D-509	12/12/2025	11:00 AM to 12:00 PM
13	2010032196	Environmental Science	D-507	13/12/2025	10:00 AM to 11:00 AM
14	2010122112	Engineering Workshop Practice	D-507	13/12/2025	11:00 AM to 12:00 PM

Important Instructions for Students appearing in above mentioned examinations:

1. University Internal backlog Examination shall be in offline mode of 40 marks.
2. They must be in their respective examination hall 15 minutes before exam time failing which entry will not be permitted.
3. Any type of printed/hand written/typed material, Mobile phone, Pager or Programmable calculator, PDA or any other objectionable material which breaches the code of conduct of university and falls under unfair means is not allowed to carry in the examination hall.
4. They must bring their own instruments such as Scientific Calculator etc., to be used in the examination as its exchange will not be permitted under any circumstances during exam time.